

N-Ch MOSFET

General Description

The WST3404A is the highest performance trench N-Ch MOSFET with extreme high cell density, which provide excellent R_{DSON} and gate charge for most of the synchronous buck converter applications.

The WST3404A meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

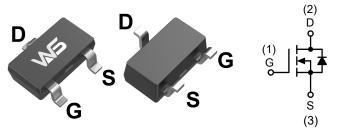
Product Summery

BV _{DSS}	R _{DSON}	Ι _D
30V	30mΩ	5.5A

Applications

- High Frequency Point-of-Load Synchronous s Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23-3L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	5.5	А
I _D @T _C =70℃	Continuous Drain Current, V _{GS} @ 10V ¹	4.5	А
I _{DM}	Pulsed Drain Current ²	20	А
EAS	Single Pulse Avalanche Energy ³	24	mJ
I _{AS}	Avalanche Current	8	А
P _D @T _A =25℃	Total Power Dissipation ⁴	1.5	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter		Max.	Unit
R _{eja}	Thermal Resistance Junction-ambient ¹		90	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹		75	°C/W



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient	Reference to $25^\circ\!\!\mathbb{C}$, I_D=1mA		0.023		V/℃	
Б	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =5.8A		30	32		
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =5A		39	44	– mΩ	
V _{GS(th)}	Gate Threshold Voltage		1.0	1.4	2.0	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	───V _{GS} =V _{DS} , I _D =250uA		-4.2		mV/℃	
	Dursin Source Lookene Surrent	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1		
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55℃			5	uA	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =6A		15		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.4	2.0	Ω	
Qg	Total Gate Charge (4.5V)			7.6	9.9		
Q _{gs}	Gate-Source Charge	V_{DS} =15V , V_{GS} =4.5V , I_D 5.8A		1.3	1.7	nC	
Q _{gd}	Gate-Drain Charge			1.7	2.2		
T _{d(on)}	Turn-On Delay Time			3.2	6.3		
Tr	Rise Time	V_{DD} =15V , V_{GS} =10V , R_{G} =6 Ω ,		10.1	20.3		
T _{d(off)}	Turn-Off Delay Time	I _D =1A, R∟=15Ω.		3	6	ns	
T _f	Fall Time			22.2	44.4		
Ciss	Input Capacitance			450			
C _{oss}	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		86.2		pF	
C _{rss}	Reverse Transfer Capacitance			59.4			

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.1mH , I _{AS} =8A	20			mJ

Diode Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}				3	А
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V , Force Current			15	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V
t _{rr}	Reverse Recovery Time	IF=8A,dI/dt=100A/µs,T」=25℃		7.8		nS
Qrr	Reverse Recovery Charge	$1F-0A$, $ui/ul-100A/\mu S$, $1j=25$ C		2.1		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =8A

4.The power dissipation is limited by 150 $^\circ\!\!\mathbb{C}$ junction temperature

5.The Min. value is 100% EAS tested guarantee.

6.The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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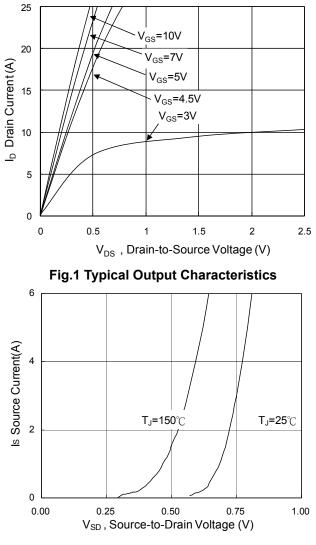
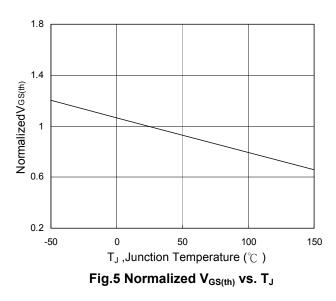


Fig.3 Forward Characteristics Of Reverse



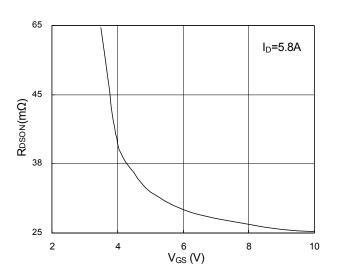


Fig.2 On-Resistance vs. Gate-Source

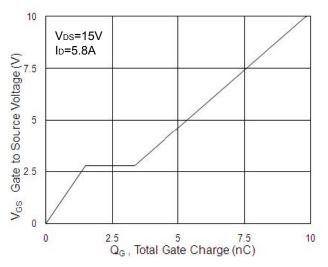
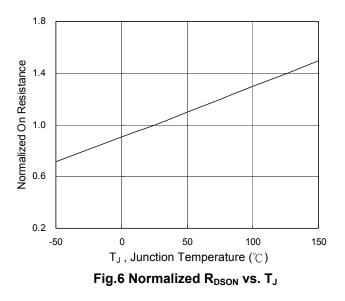


Fig.4 Gate-Charge Characteristics





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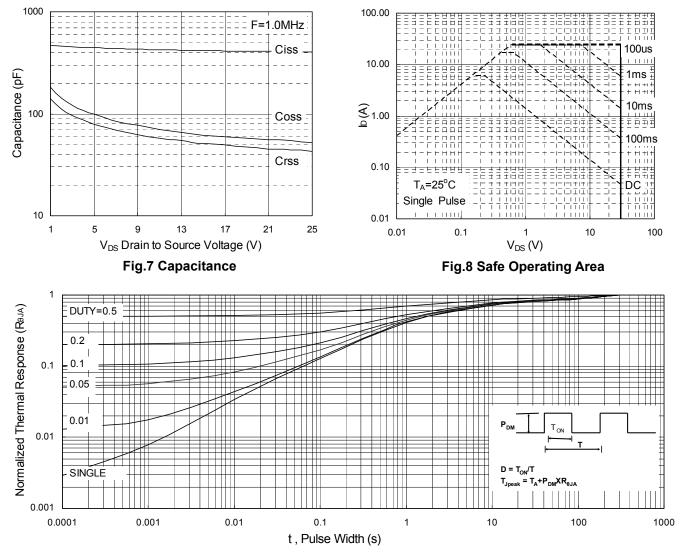
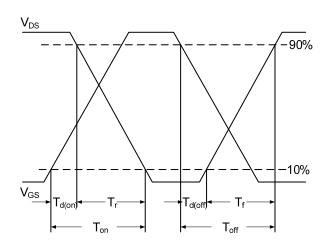
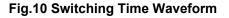


Fig.9 Normalized Maximum Transient Thermal Impedance





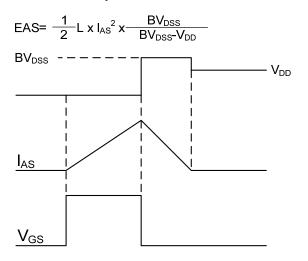


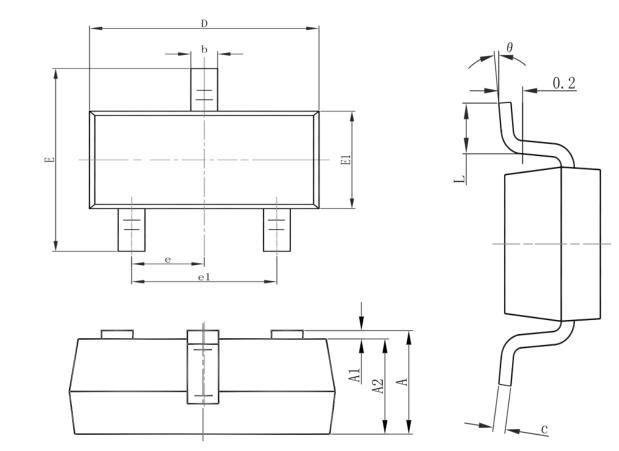
Fig.11 Unclamped Inductive Switching Waveform



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WST3404A

Packaging information



Complete L	Dimensions In Millimeters		Dimensio	ns In Inches
Symbol	Min.	Max.	Min.	Max.
А	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
с	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.03	7(BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°



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